

## Patent Assignment Abstract of Title

**Total Assignments: 1**
**Application #:** 10603593 **Filing Dt:** 06/25/2003

**Patent #:** NONE

**Issue Dt:**
**PCT #:** NONE

**Publication #:** NONE

**Pub Dt:**
**Inventor:** Yogesh Swami

**Title:** System and method for optimizing link throughput in response to non-congestion-related packet loss

**Assignment: 1**

<b>Reel/Frame:</b> <u>014526/0654</u>	<b>Received:</b> 09/30/2003	<b>Recorded:</b> 09/26/2003	<b>Mailed:</b> 04/23/2004
			<b>Pages:</b> 3

**Conveyance:** ASSIGNMENT OF ASSIGNORS INTEREST (SEE DOCUMENT FOR DETAILS).

**Assignor:** SWAMI, YOGESH
**Exec Dt:** 07/30/2003

**Assignee:** NOKIA CORPORATION

 KEILALAHDENTIE 4  
 FIN-02150 ESPOO, FINLAND

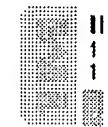
**Correspondent:** CRAWFORD MAUNU PLLC

 STEVEN R. FUNK  
 1270 NORTHLAND DRIVE, SUITE 390  
 ST. PAUL, MN 55120

Search Results as of: 11/13/2004 12:52:03 P.M.

---

If you have any comments or questions concerning the data displayed, contact OPR / Assignments at 703-308-9723  
 Web interface last modified: Oct. 5, 2002



» See



## Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

## Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

## Search

- By Author
- Basic
- Advanced
- CrossRef

## Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

## IEEE Enterprise

- Access the IEEE Enterprise File Cabinet





Membership Publications/Services Standards Conferences Careers/Jobs

**IEEE Xplore®**  
RELEASE 1.8Welcome  
United States Patent and Trademark Office

Help FAQ Terms IEEE Peer Review

Quick Links

» Sea

## Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

## Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

## Search

- By Author
- Basic
- Advanced
- CrossRef

## Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

## IEEE Xplore®

- Access the IEEE Enterprise File Cabinet

 Print Format

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved

## Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

## Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

## Search

- By Author
- Basic
- Advanced
- CrossRef

## Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

## IEEE Enterprise

- Access the IEEE Enterprise File Cabinet

 Print Format

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved